

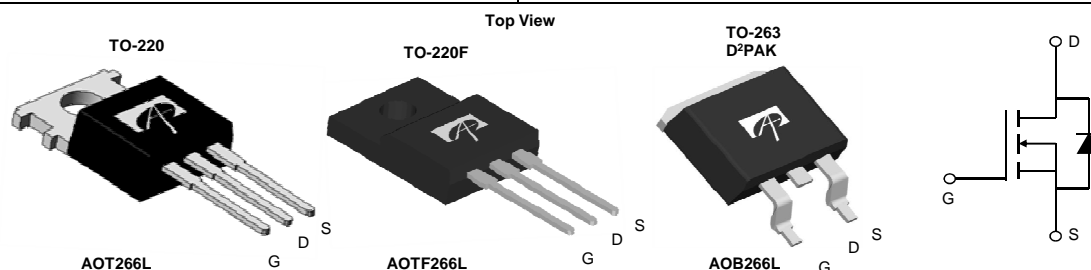
General Description

The AOT266L & AOB266L & AOTF266L uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$, C_{iss} and C_{oss} . This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

V_{DS}	60V
I_D (at $V_{GS}=10V$)	140A/78A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 3.5m Ω (< 3.2m Ω^*)
$R_{DS(ON)}$ (at $V_{GS}=6V$)	< 4.0m Ω (< 3.8m Ω^*)

100% UIS Tested
 100% R_g Tested



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT266L	TO220 Green	Tube	1000
AOTF266L	TO220F Green	Tube	1000
AOB266L	TO263 Green	Tape & Reel	800

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOT266L/AOB266L	AOTF266L	Units
Drain-Source Voltage	V_{DS}	60		V
Gate-Source Voltage	V_{GS}	± 20		V
Continuous Drain Current ^G	I_D	$T_C=25^\circ\text{C}$	140	78
		$T_C=100^\circ\text{C}$	110	55
Pulsed Drain Current ^C	I_{DM}	450		A
Continuous Drain Current	I_{DSM}	$T_A=25^\circ\text{C}$	18	
		$T_A=70^\circ\text{C}$	14	
Avalanche Current ^C	I_{AS}	90		A
Avalanche energy $L=0.1\text{mH}$ ^C	E_{AS}	405		mJ
Power Dissipation ^B	P_D	$T_C=25^\circ\text{C}$	268	45.5
		$T_C=100^\circ\text{C}$	134	22.5
Power Dissipation ^A	P_{DSM}	$T_A=25^\circ\text{C}$	2.1	
		$T_A=70^\circ\text{C}$	1.3	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175		$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	AOT266L/AOB266L	AOTF266L	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	15	15	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^{A,D}		Steady-State	60	60
Maximum Junction-to-Case	$R_{\theta JC}$	0.56	3.3	$^\circ\text{C/W}$

* Surface mount package TO263

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.2	2.7	3.2	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A TO220/TO220F T _J =125°C		2.9	3.5	mΩ
		V _{GS} =6V, I _D =20A TO220/TO220F		3.2	4	
		V _{GS} =10V, I _D =20A TO263		2.6	3.2	mΩ
		V _{GS} =6V, I _D =20A TO263		3	3.8	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A		80		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.65	1	V
I _S	Maximum Body-Diode Continuous Current ^G				140	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz		5650		pF
C _{oss}	Output Capacitance			720		pF
C _{rss}	Reverse Transfer Capacitance			20		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	0.4	0.9	1.4	Ω
SWITCHING PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A		65	90	nC
Q _{gs}	Gate Source Charge			20		nC
Q _{gd}	Gate Drain Charge			7		nC
t _{D(on)}	Turn-On Delay Time	V _{GS} =10V, V _{DS} =30V, R _L =1.5Ω, R _{GEN} =3Ω		21		ns
t _r	Turn-On Rise Time			20		ns
t _{D(off)}	Turn-Off Delay Time			36		ns
t _f	Turn-Off Fall Time			6		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		27		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		145		nC

A. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

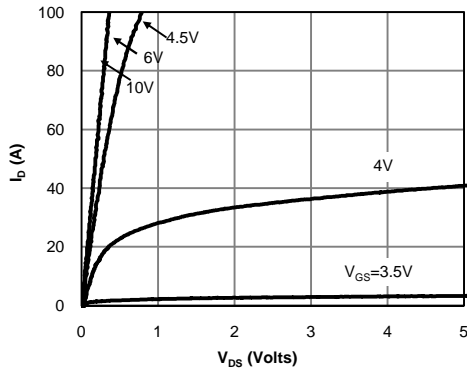


Figure 1: On-Region Characteristics (Note E)

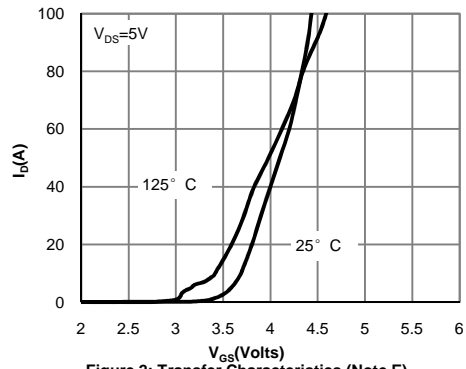


Figure 2: Transfer Characteristics (Note E)

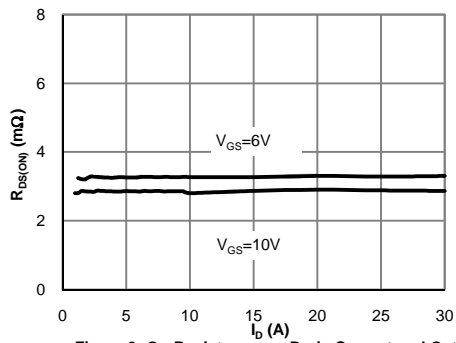


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

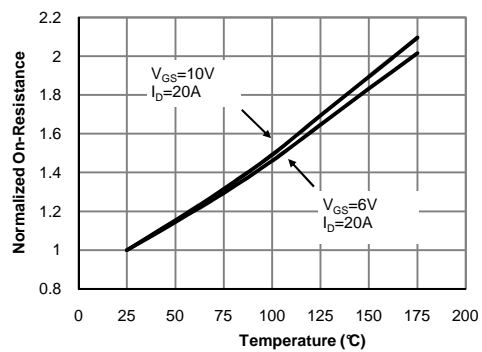


Figure 4: On-Resistance vs. Junction Temperature (Note E)

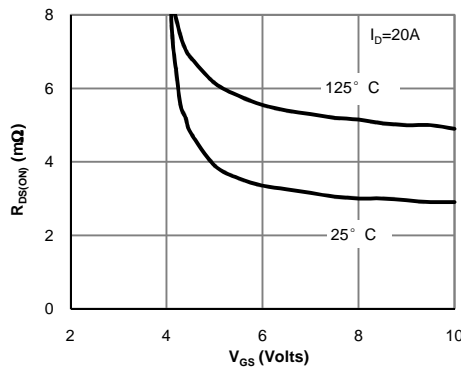


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

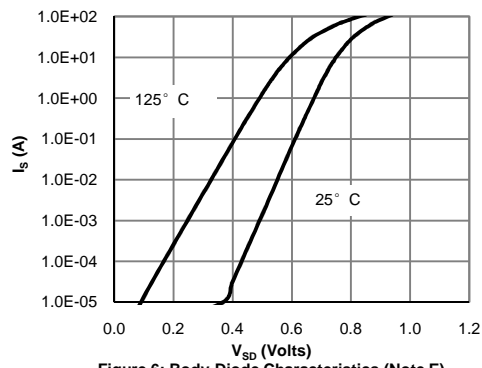


Figure 6: Body-Diode Characteristics (Note E)

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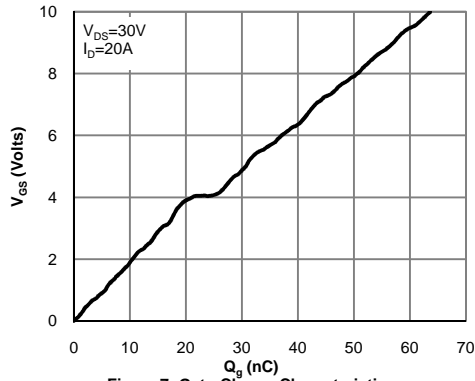


Figure 7: Gate-Charge Characteristics

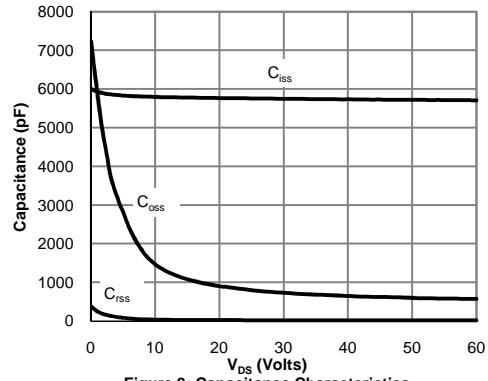


Figure 8: Capacitance Characteristics

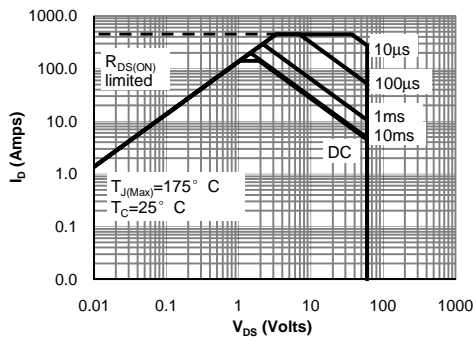


Figure 9: Maximum Forward Biased Safe Operating Area for AOT266L and AOB266L (Note F)

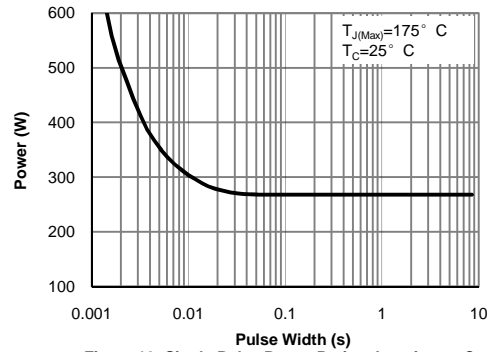


Figure 10: Single Pulse Power Rating Junction-to-Case for AOT266L and AOB266L (Note F)

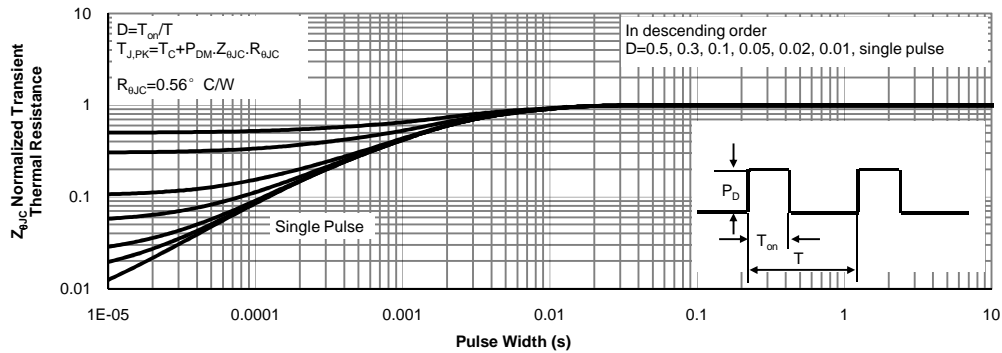


Figure 11: Normalized Maximum Transient Thermal Impedance for AOT266L and AOB266L (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

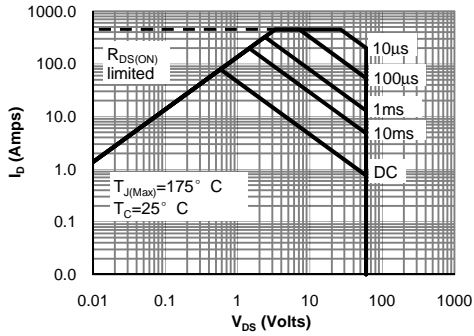


Figure 12: Maximum Forward Biased Safe Operating Area for AOTF266L (Note F)

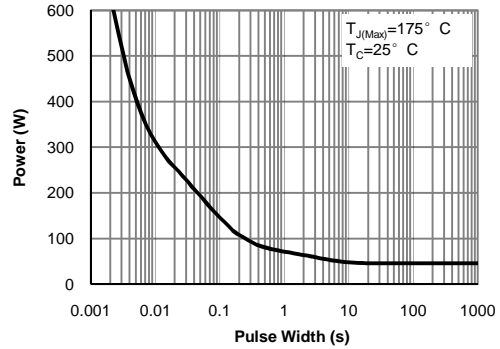


Figure 13: Single Pulse Power Rating Junction-to-Case for AOTF266L (Note F)

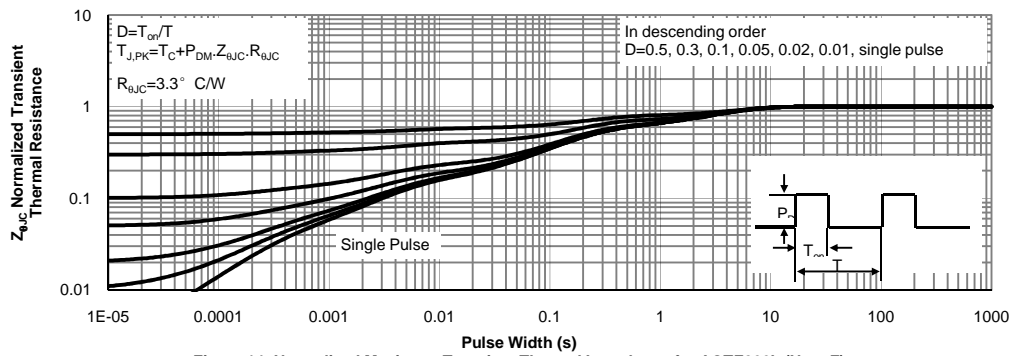


Figure 14: Normalized Maximum Transient Thermal Impedance for AOTF266L (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

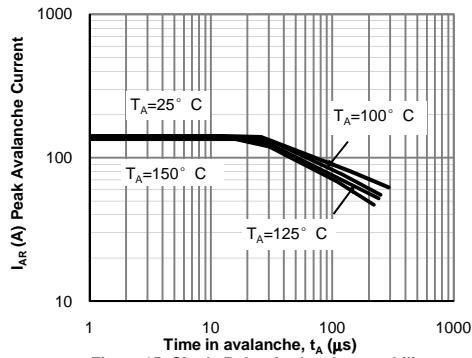


Figure 15: Single Pulse Avalanche capability (Note C)

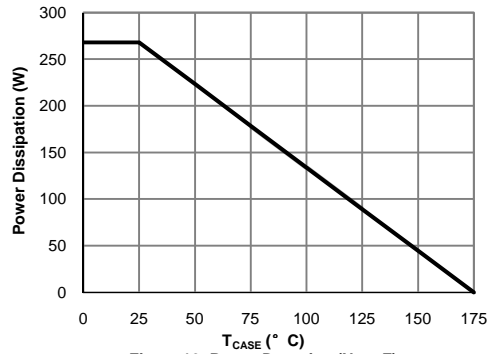


Figure 16: Power De-rating (Note F)

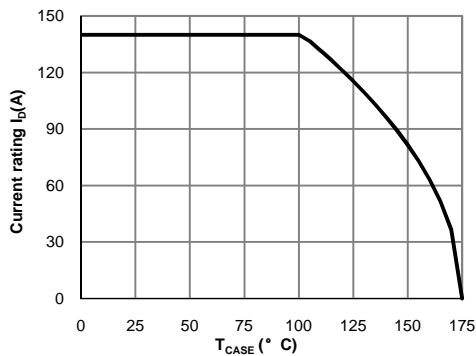


Figure 17: Current De-rating (Note F)

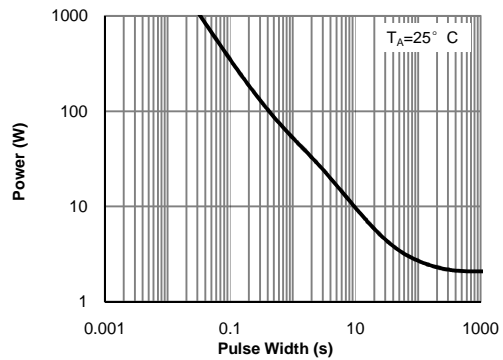


Figure 18: Single Pulse Power Rating Junction-to-Ambient (Note H)

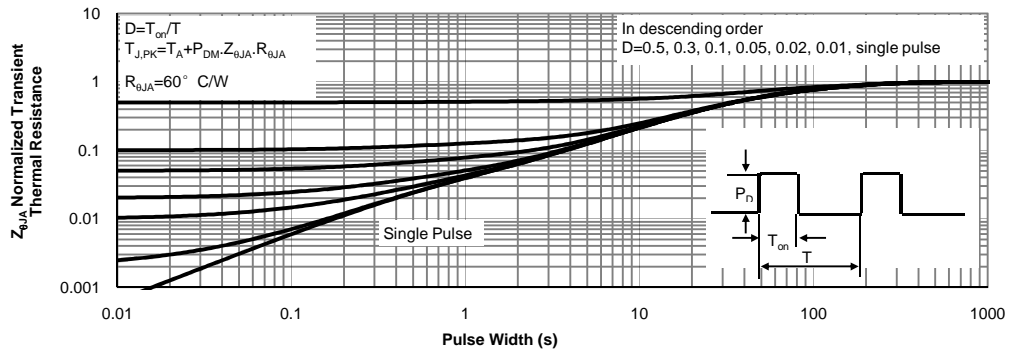
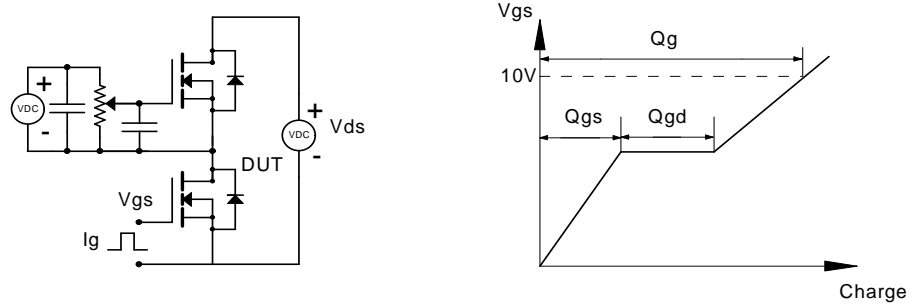
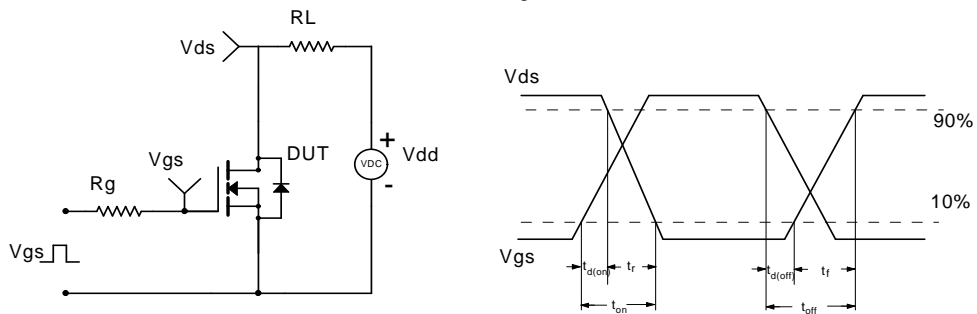


Figure 19: Normalized Maximum Transient Thermal Impedance (Note H)

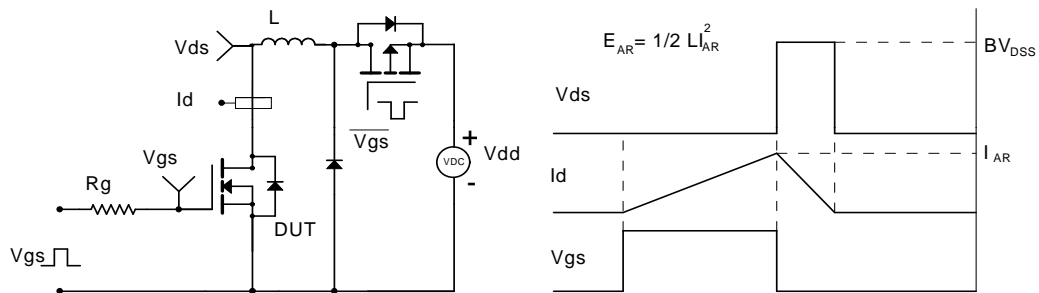
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

